

## 1. General Description

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The EM74HCS4075 is a triple 3-input OR gate with Schmitt-trigger inputs. Inputs include clamp diodes. This enables the use of current limiting resistors to interface inputs to voltages in excess of  $V_{CC}$ .

## 2. Features and Benefits

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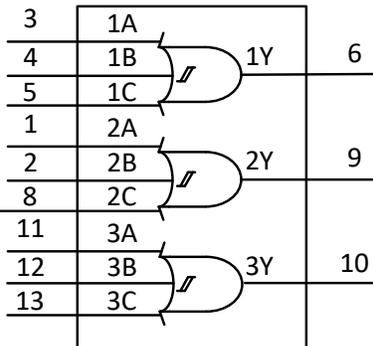
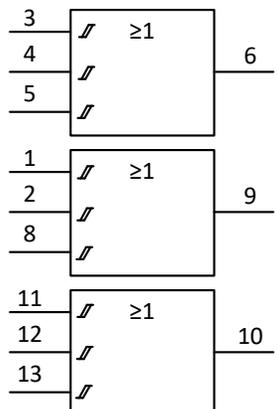
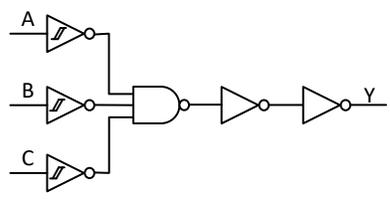
- Wide supply voltage range from 2.0 V to 6.0 V
- High noise immunity
- CMOS low power dissipation
- Latch-up performance exceeds 250 mA
- Unlimited rise and fall times
- Complies with JEDEC standards:
  - JESD8C (2.7 V to 3.6 V)
  - JESD7A (2.0 V to 6.0 V)
- ESD protection:
  - HBM ANSI/ESDA/JEDEC JS-001 Class 2 exceeds 3500 V
  - CDM ANSI/ESDA/JEDEC JS-002 Class C3 exceeds 2000 V
- Multiple package options

### 3. Ordering Information

Table 1. Ordering information

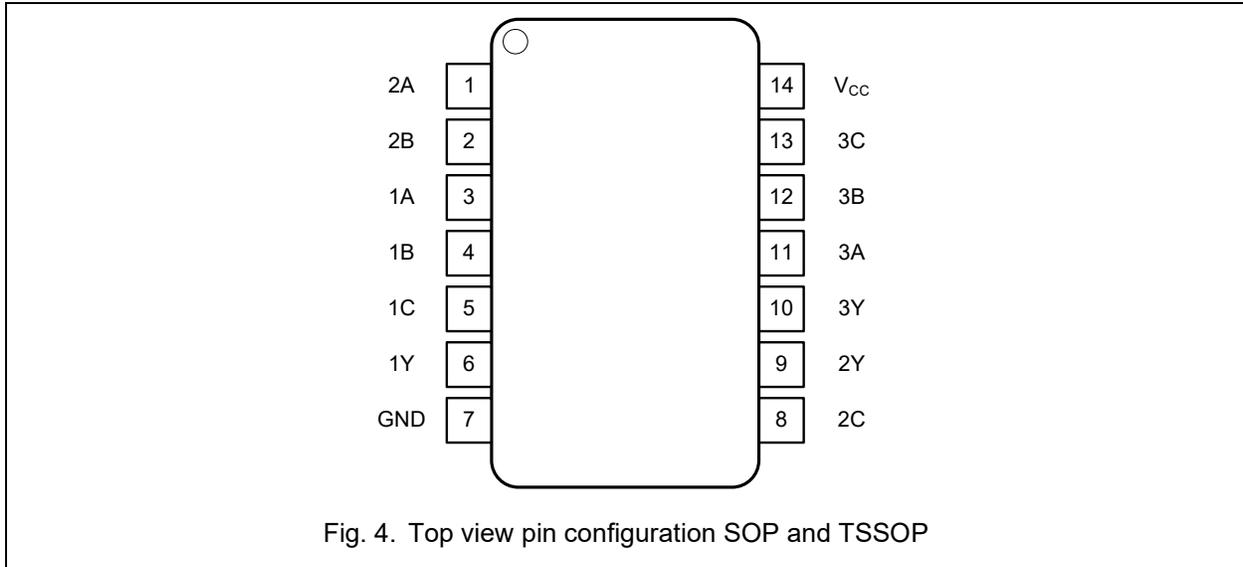
Type number	Package		
	Name	Description	Quantity
EM74HCS4075D	SOP-14L	plastic small outline package; 14 leads; body width 3.9 mm	3000
EM74HCS4075PW	TSSOP-14L	plastic thin shrink small outline package; 14 leads; body width 4.4 mm	3000

### 4. Function Diagram

 <p style="text-align: center;">Fig. 1. Logic symbol</p>	 <p style="text-align: center;">Fig. 2. IEC logic symbol</p>	 <p style="text-align: center;">Fig. 3. Logic diagram(one gate)</p>
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## 5. Pinning Information

### 5.1. Pinning



### 5.2. Pin description

Table 2. Pin description

Symbol	Pin	Description
1A, 2A, 3A	3, 1, 11	Data input
1B, 2B, 3B	4, 2, 12	Data input
1C, 2C, 3C	5, 8, 13	Data input
1Y, 2Y, 3Y	6, 9, 10	Data output
GND	7	Ground (0V)
V <sub>cc</sub>	14	Supply voltage

## 6. Functional Description

**Table 3. Function table**

H = HIGH voltage level; L = LOW voltage level; X = don't care.

Control			Output
nA	nB	nC	nY
L	L	L	L
X	X	H	H
X	H	X	H
H	X	X	H

## 7. Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

**Table 4. Absolute Maximum Ratings**

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND.

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		-0.5	7.0	V
$I_{IK}$	input clamping current	$V_I < -0.5\text{ V}$ or $V_I > V_{CC} + 0.5\text{ V}$ [1]		$\pm 20$	mA
$I_{OK}$	output clamping current	$V_O < -0.5\text{ V}$ or $V_O > V_{CC} + 0.5\text{ V}$ [1]		$\pm 20$	mA
$I_O$	output current	$V_O = -0.5\text{ V}$ to $(V_{CC} + 0.5\text{ V})$		$\pm 35$	mA
$I_{CC}$	supply current			70	mA
$I_{GND}$	ground current		-70		mA
$P_{tot}$	total power dissipation			500	mW
$T_{stg}$	storage temperature		-65	150	°C

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

## 8. Recommended Operating Conditions

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. EnergyMath does not recommend exceeding them or designing to Absolute Maximum Ratings.

**Table 5. Recommended Operating Conditions**

Symbol	Parameter	Conditions	EM74HCS4075			Unit
			Min	Typ	Max	
V <sub>CC</sub>	supply voltage		2.0	5.0	6.0	V
V <sub>I</sub>	input voltage		0		V <sub>CC</sub>	V
V <sub>O</sub>	output voltage		0		V <sub>CC</sub>	V
T <sub>amb</sub>	ambient temperature		-40		125	°C

## 9. Static Characteristics

**Table 6. Static characteristics**

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V). Typical values measured at  $T_{amb} = 25^{\circ}\text{C}$  (unless otherwise noted).

Symbol	Parameter	Conditions	-40 °C to +85 °C			-40 °C to +125 °C		Unit
			Min	Typ	Max	Min	Max	
$V_{OH}$	HIGH-level output voltage	$V_I = V_{T+}$ or $V_{T-}$						
		$I_O = -20 \mu\text{A}; V_{CC} = 2.0 \text{ V}$	1.9			1.9		V
		$I_O = -20 \mu\text{A}; V_{CC} = 4.5 \text{ V}$	4.4			4.4		V
		$I_O = -20 \mu\text{A}; V_{CC} = 6.0 \text{ V}$	5.9			5.9		V
		$I_O = -6.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.84			3.7		V
		$I_O = -7.8 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.34			5.2		V
$V_{OL}$	LOW-level output voltage	$V_I = V_{T+}$ or $V_{T-}$						
		$I_O = 20 \mu\text{A}; V_{CC} = 2.0 \text{ V}$			0.1		0.1	V
		$I_O = 20 \mu\text{A}; V_{CC} = 4.5 \text{ V}$			0.1		0.1	V
		$I_O = 20 \mu\text{A}; V_{CC} = 6.0 \text{ V}$			0.1		0.1	V
		$I_O = 6.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$			0.33		0.4	V
		$I_O = 7.8 \text{ mA}; V_{CC} = 6.0 \text{ V}$			0.33		0.4	V
$I_I$	input leakage current	$V_I = V_{CC}$ or GND ; $V_{CC} = 6.0 \text{ V}$			$\pm 1$		$\pm 1$	$\mu\text{A}$
$I_{CC}$	supply current	$V_I = V_{CC}$ or GND ; $I_O = 0 \text{ A}$ ; $V_{CC} = 6.0 \text{ V}$			1		2	$\mu\text{A}$
$C_I$	input capacitance			7				pF

## 10. Dynamic Characteristics

**Table 7. Dynamic characteristics**

Voltages are referenced to GND (ground = 0 V); for test circuit see Fig. 6. Typical values measured at  $T_{amb} = 25^{\circ}\text{C}$  (unless otherwise noted).

Symbol	Parameter	Conditions	-40 °C to +85 °C			-40 °C to +125 °C		Unit
			Min	Typ	Max	Min	Max	
$t_{pd}$	propagation delay	nA to nY; see Fig. 5 [1]						
		$V_{CC} = 2.0\text{ V}$			35		40	ns
		$V_{CC} = 4.5\text{ V}$			20		25	ns
		$V_{CC} = 6.0\text{ V}$			15		20	ns
$t_t$	transition time	see Fig. 5 [2]						
		$V_{CC} = 2.0\text{ V}$			9		11	ns
		$V_{CC} = 4.5\text{ V}$			6		8	ns
		$V_{CC} = 6.0\text{ V}$			4		5	ns
$C_{PD}$	power dissipation capacitance	$C_L = 15\text{ pF}$ ; $f = 1\text{ MHz}$ ; $V_I = \text{GND to } V_{CC}$ [3]		18				pF

[1]  $t_{pd}$  is the same as  $t_{PHL}$  and  $t_{PLH}$ .

[2]  $t_t$  is the same as  $t_{THL}$  and  $t_{TLH}$ .

[3]  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu\text{W}$ ).

$$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum(C_L \times V_{CC}^2 \times f_o) \text{ where:}$$

$f_i$  = input frequency in MHz;

$f_o$  = output frequency in MHz;

$C_L$  = output load capacitance in pF;

$V_{CC}$  = supply voltage in V;

$N$  = number of inputs switching;

$\sum(C_L \times V_{CC}^2 \times f_o)$  = sum of outputs.

### 10.1. Waveforms and test circuit

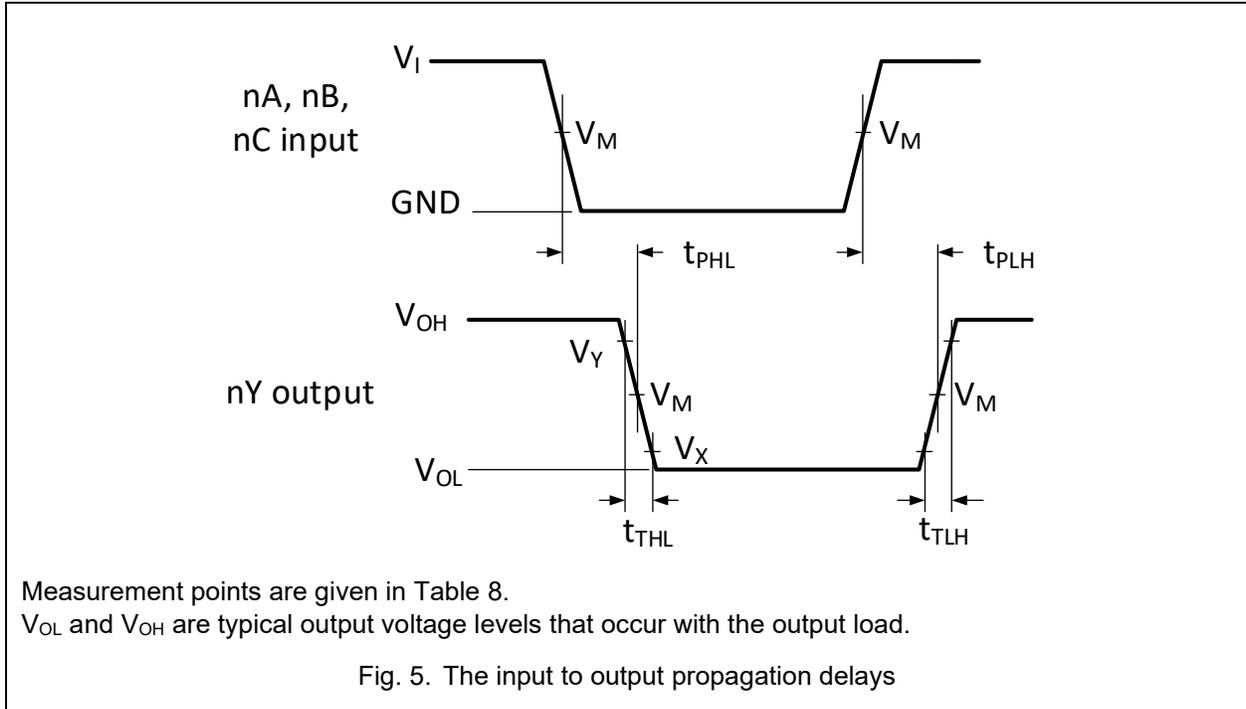


Table 8. Measurement points

Type	Input	Output		
	$V_M$	$V_M$	$V_X$	$V_Y$
EM74HCS4075	$0.5V_{CC}$	$0.5V_{CC}$	$0.1V_{CC}$	$0.9V_{CC}$

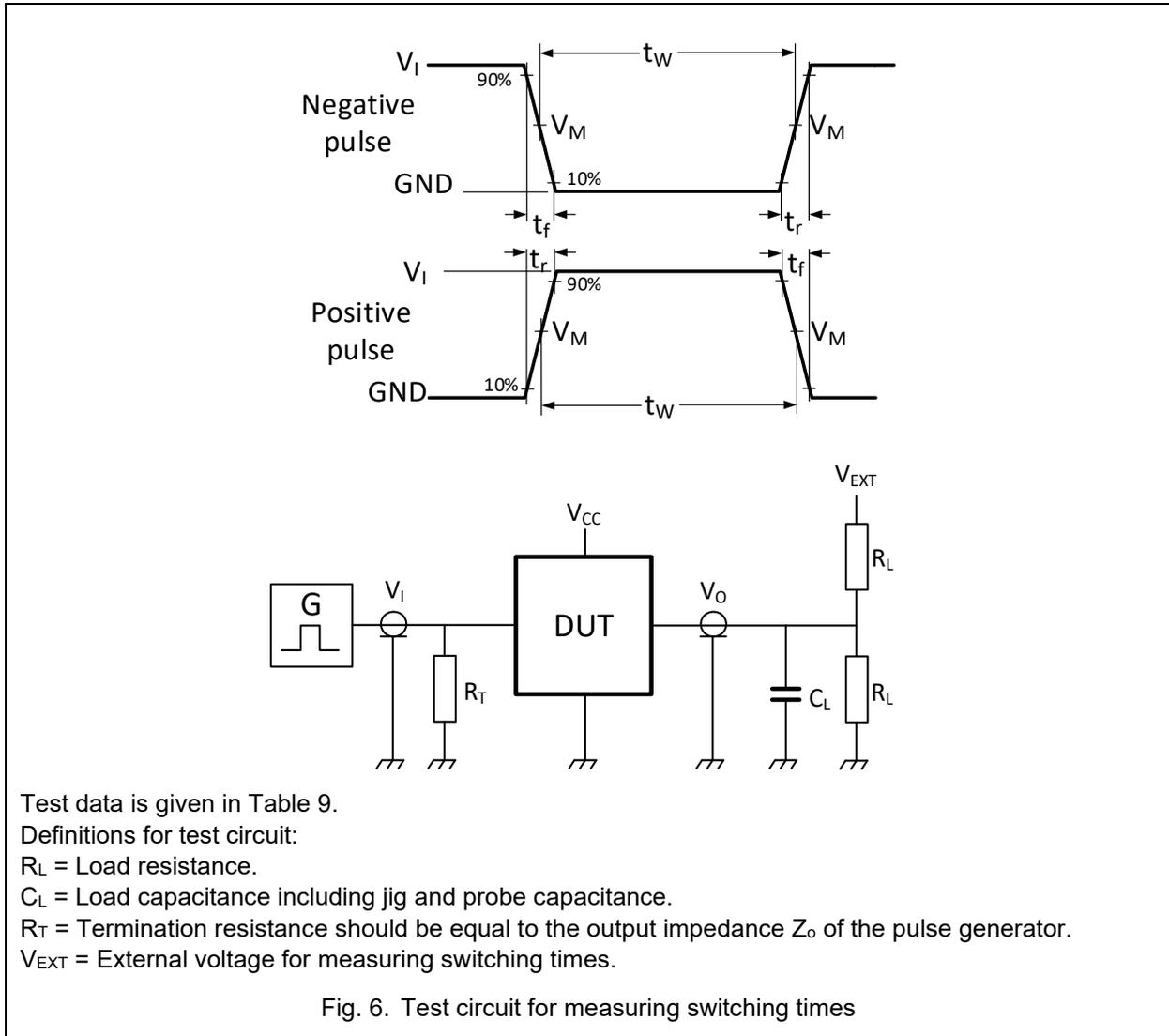


Table 9. Test data

Type	Input		Load		$V_{EXT}$
	$V_I$	$t_r = t_f$	$C_L$	$R_L$	$t_{PLH}, t_{PHL}$
EM74HCS4075	$V_{CC}$	$\leq 2.5$ ns	15 pF	500 $\Omega$	open

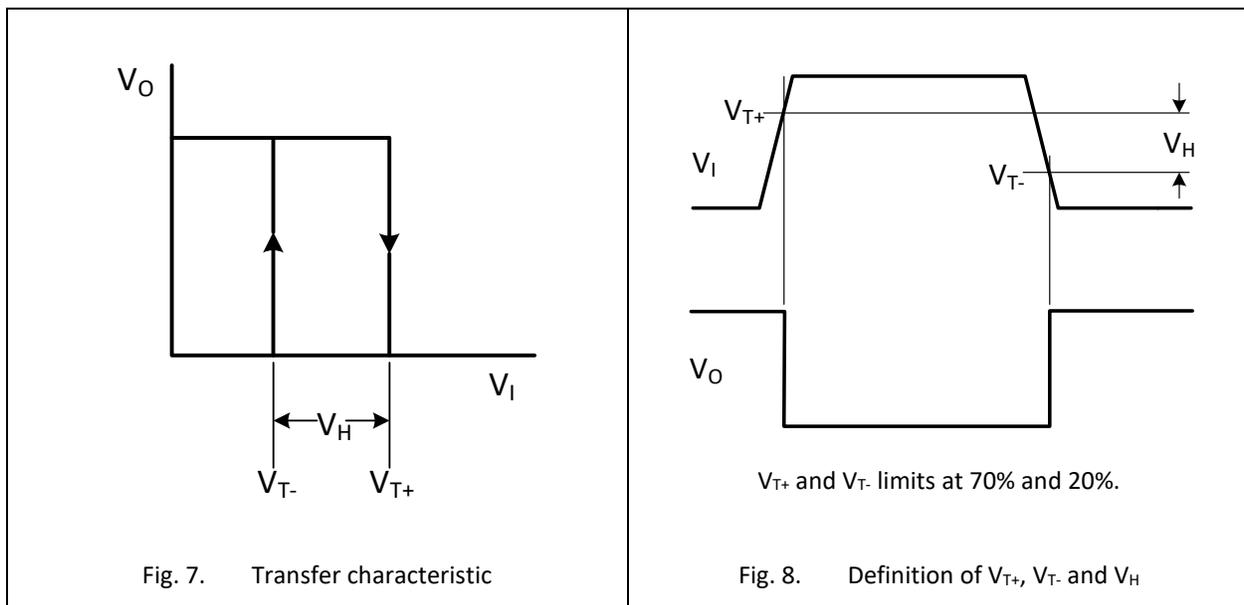
# 11. Transfer Characteristics

**Table 10. Transfer characteristics**

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V). Typical values are measured at  $T_{amb} = 25^{\circ}\text{C}$ .

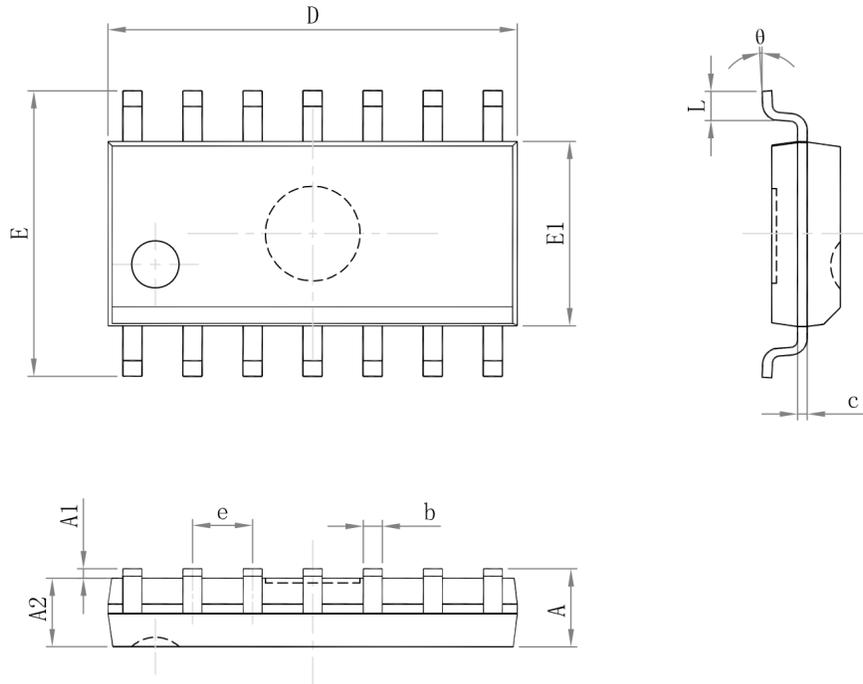
Symbol	Parameter	Conditions	-40 °C to +85 °C			-40 °C to +125 °C		Unit
			Min	Typ	Max	Min	Max	
$V_{T+}$	positive-going threshold voltage	see Fig. 7 and Fig. 8						
		$V_{CC} = 2.0\text{ V}$	0.7	1.21	1.5	0.7	1.5	V
		$V_{CC} = 4.5\text{ V}$	1.7	2.39	3.15	1.7	3.15	V
		$V_{CC} = 6.0\text{ V}$	2.1	3.05	4.2	2.1	4.2	V
$V_{T-}$	negative-going threshold voltage	see Fig. 7 and Fig. 8						
		$V_{CC} = 2.0\text{ V}$	0.3	0.6	0.9	0.3	0.9	V
		$V_{CC} = 4.5\text{ V}$	0.9	1.41	2.0	0.9	2.0	V
		$V_{CC} = 6.0\text{ V}$	1.2	1.9	2.6	1.2	2.6	V
$V_H$	hysteresis voltage	see Fig. 7 and Fig. 8						
		$V_{CC} = 2.0\text{ V}$	0.2	0.61	1.0	0.2	1.0	V
		$V_{CC} = 4.5\text{ V}$	0.4	0.97	1.4	0.4	1.4	V
		$V_{CC} = 6.0\text{ V}$	0.6	1.16	1.6	0.6	1.6	V

## 11.1. Waveforms transfer characteristics



## 12. Package Outline

SOP-14L

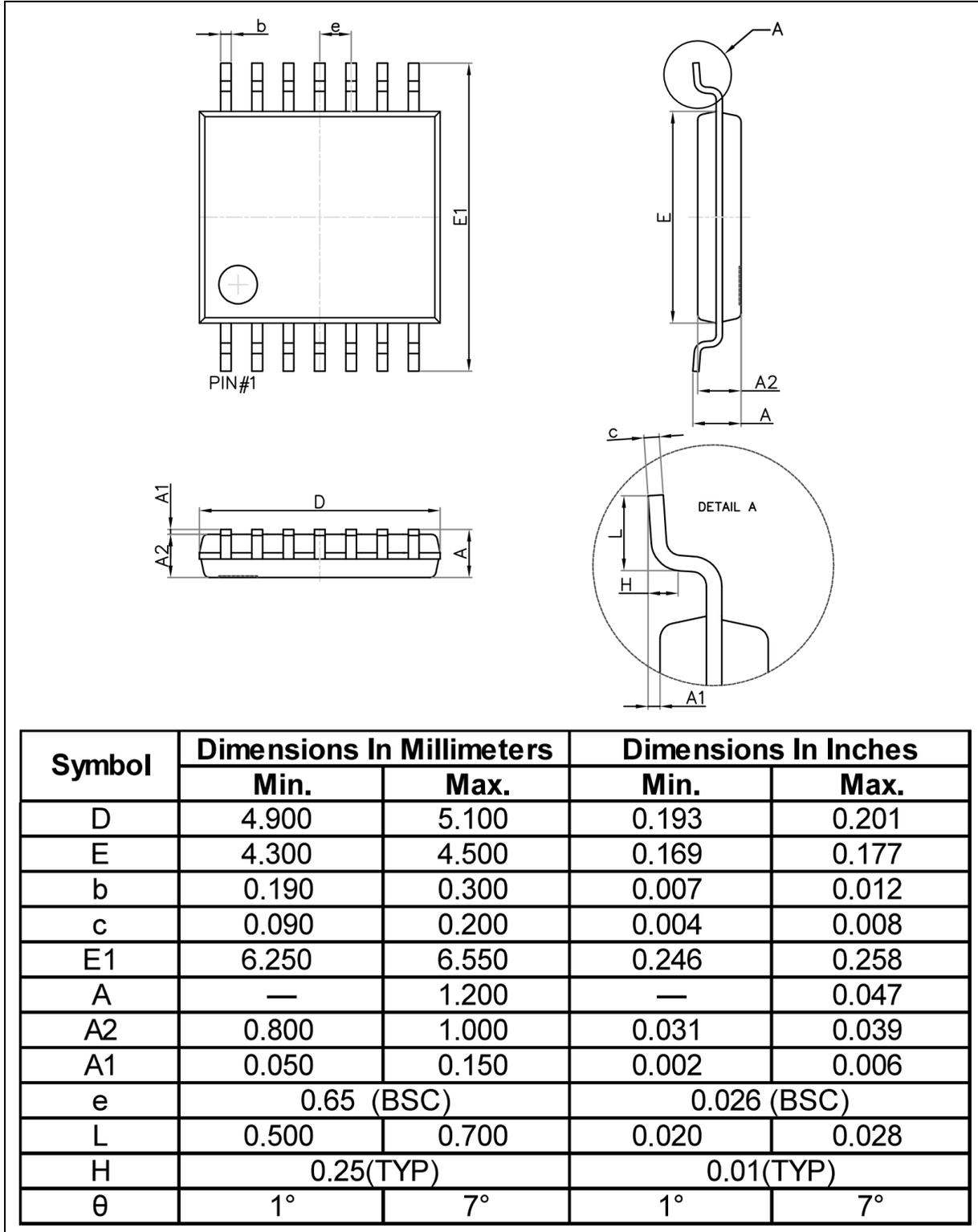


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	--	1.750	--	0.069
A1	0.100	0.250	0.004	0.010
A2	1.250	--	0.049	--
b	0.310	0.510	0.012	0.020
c	0.100	0.250	0.004	0.010
D	8.450	8.850	0.333	0.348
E	5.800	6.200	0.228	0.244
E1	3.800	4.000	0.150	0.157
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
$\theta$	0°	8°	0°	8°

**EM74HCS4075**

Triple 3-input OR Schmitt trigger

**TSSOP-14L**



## 13. Abbreviations

**Table 11. Abbreviations**

Acronym	Description
CMOS	Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
CDM	Charged Device Model

## 14. Revision History

**Table 12. Revision history**

Document ID	Release Date	Data sheet status	Change notice	Supersedes
EM74HC_HCT4075 Rev. 1.0	Aug 30, 2024	Product datasheet		